

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/523,548	<b>Applicant(s)/Patent under Reexamination</b> LICH, THOMAS
	<b>Examiner</b> Mariano Sy	<b>Art Unit</b> 3683

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner